

U.S. PATENT DOCUMENTS

**FOREIGN PATENT DOCUMENTS**

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\*EXAMINER Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant. \* CITE NO. Those application(s) which are marked with an single asterisk (\*) next to the Cite No. are not supplied (under 37 CFR 1.98(a)(2)(ii)) because that application was filed after April 30, 2003 or is available in the IFW. Applicant's unique citation designation number (optional). See Kinds/Code of USPTO Patent Documents at [www.uspto.gov/mpep/601-041.htm](http://www.uspto.gov/mpep/601-041.htm) Enter Office that issued the patent. If the patent is a foreign patent, the indicator of the year of the grant of the patent by the foreign office must be placed in the space provided. Enter the serial number of the patent document. Kind of document by the appropriate symbols as indicated on the document under WIPO Standard St. 16 if possible. \* Applicant is to place a check mark here if English language Translation is attached.

Substitute for form 1449-PTO  <b>INFORMATION DISCLOSURE STATEMENT BY APPLICANT</b>  <i>(Use as many sheets as necessary)</i>			Complete if Known	
	Application Number	10/599,036-Conf. #3301		
	Filing Date	September 18, 2006		
	First Named Inventor	Teruo Amoh		
	Art Unit	2894		
	Examiner Name	A. Belousov		
	Attorney Docket Number	20239/0204318-US0		
Sheet	2	of	2	

NON PATENT LITERATURE DOCUMENTS			
Examiner Initials	Cite No. <sup>1</sup>	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	T <sup>2</sup>
	CA	SONG J O et al: " Low-resistance and highly-reflective Zn-Ni solid solution/Ag ohmic contacts for flip-chip light-emitting diodes" APPLIED PHYSICS LETTERS AIP USA, vol. 83, no. 24, December 15, 2003, pages 4990-4992, XP002522288	

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<sup>2</sup>Applicant's unique citation designation number (optional). <sup>3</sup>Applicant is to place a check mark here if English language Translation is attached.